

200107606-6

(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization
International Bureau



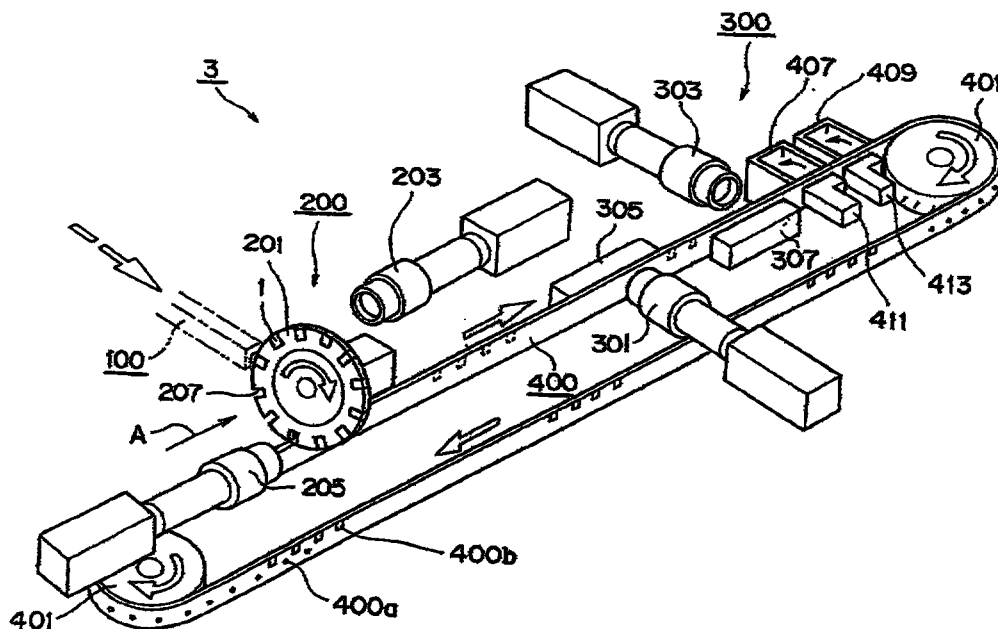
(43) International Publication Date
8 February 2001 (08.02.2001)

PCT

(10) International Publication Number
WO 01/09013 A1

- (51) International Patent Classification⁷: B65G 17/32, B23Q 17/24, G01R 31/01
- (21) International Application Number: PCT/JP00/04692
- (22) International Filing Date: 13 July 2000 (13.07.2000)
- (25) Filing Language: English
- (26) Publication Language: English
- (30) Priority Data: 11/217350 30 July 1999 (30.07.1999) JP
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- (81) Designated States (*national*): CN, IL, KR, MX, SG.
- Published:
— With international search report.
— With amended claims and statement.
- For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.*

(54) Title: WORKPIECE INSPECTION APPARATUS AND INSPECTION METHOD



(57) Abstract: A workpiece inspection apparatus (3) for inspecting the faces of polyhedral workpieces (1) is equipped with at least one endless conveyor belt (400) having a plurality of cutaway portions (400b) formed therein for holding the workpieces, and inspection devices (301, 303) to inspect the exposed faces of the workpieces held in the cutaway portions of the conveyor belt.

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